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Form PTO 1449	449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO.		SERIAL NO.	
(Modified)		PATENT AND TRAD	EMARK OFFICE	260903US2PCT		10/511,447	
				APPLICANT			
LIST OF	REFEF	RENCES CITED BY AP	PLICANT	Hiroshi TAKAHARA, et al.			
				FILING DATE		GROUP	
				October 26, 2004		2629	
U.S. PATENT DOCUMENTS							
EXAMINER		DOCUMENT	DATE	NAME	CLASS	SUB	FILING DATE
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO	
	AO	06-332397	12/02/94	Japan (w/English abstract)			X
	AP	2002-297096	10/09/02	Japan (w/English abstract)			X
	AQ	2001-0070173	07/25/01	Korea (corresponds to US 2003/201448)			X
	AR	2001-0078229	08/20/01	Korea (corresponds to US 2001/040645)			X
	AS	2003-0000146	01/06/03	Korea (corresponds to US 2002/196214)			Х
	AT	2003-0025185	03/28/03	Korea (corresponds to US 2003/052597)			X
	AU	2002-0069488	09/0402	Korea (corresponds to US 2002/175635)			X
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
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	AY						
	AZ			Additional References sheet(s) attached			
Examiner					Date Considered		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							
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